

EAST - [029521d:1]

File View Edit Tools Window Help

Pending

Active

- L1: (63) extract\$4 same befor\$1 same recipe
- L2: (19) extract\$4 same befor\$1 same recipe same process\$4
- L3: (13) interfac\$4 and 12
- L4: (5) interfac\$4 and mask and 12
- L5: (5) interfac\$4 and mask and wafer and 12
- L6: (21) interfac\$4 and mask and wafer and process\$4 and 11

Failed

DB: USPAT, USP, Pubs

Default operator: OR Highlight all hit terms exactly

interfac\$4 and mask and wafer and process\$4 and 11

Ans. 13s 2m 2s 1m 1s

	U	I	Document ID	Iss	Title	Current	Ci
1	<input type="checkbox"/>	<input type="checkbox"/>	US 20030237064	20	Characterization and verification for integrated circuit des	716/5	71
2	<input type="checkbox"/>	<input type="checkbox"/>	US 20030229881	20	Adjustment of masks for integrated circuit fabrication	716/19	
3	<input type="checkbox"/>	<input type="checkbox"/>	US 20030229880	20	Test masks for lithographic and etch processes	716/19	
4	<input type="checkbox"/>	<input type="checkbox"/>	US 20030229868	20	Electronic design for integrated circuits based process rela	716/5	
5	<input type="checkbox"/>	<input type="checkbox"/>	US 20030229412	20	Electronic design for integrated circuits based on process r	700/121	71
6	<input type="checkbox"/>	<input type="checkbox"/>	US 20030058444	20	Inspection method, apparatus and system for circuit pattern	356/394	
7	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20020113967	20	Inspection method, apparatus and system for circuit pattern	356/394	
8	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20020109088	20	Inspection method, apparatus and system for circuit pattern	250/306	25
9	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20020105648	20	Inspection method, apparatus and system for circuit pattern	356/394	
10	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20010021020	20	Inspection method, apparatus and system for circuit pattern	356/394	25
11	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20010021019	20	Inspection method, apparatus and system for circuit pattern	356/394	
12	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20010019411	20	Inspection method, apparatus and system for circuit pattern	356/394	25
13	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20010015805	20	Inspection method, apparatus and system for circuit pattern	356/394	
14	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 20010011706	20	Inspection method, apparatus and system for circuit pattern	250/397	
15	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6567168	B2 20	Inspection method, apparatus and system for circuit pattern	356/394	25
16	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6504609	B2 20	Inspection method, apparatus and system for circuit pattern	356/394	
17	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6493082	B2 20	Inspection method, apparatus and system for circuit pattern	356/394	36
18	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6480279	B2 20	Inspection method, apparatus and system for circuit pattern	356/394	36
19	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6476913	B1 20	Inspection method, apparatus and system for circuit pattern	356/394	
20	<input checked="" type="checkbox"/>	<input type="checkbox"/>	US 6421122	B2 20	Inspection method, apparatus and system for circuit pattern	356/394	36
21	<input type="checkbox"/>	<input type="checkbox"/>	US 6388747	B2 20	Inspection method, apparatus and system for circuit pattern	356/394	

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13s 2m 2s 1m 1s

Ready

HOME